Silicon Nitride from Organosilazane Cyclic and Linear Prepolymers

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Silicon nitride coatings are generally produced by CVD techniques which involve mixtures of gases, typically SiH4/NH3 or SiCl4 /NH₂ in carriers. The fabrication passivation layers and dielectic coatings demand consistent electrical, mechanical and etch (chemical) properties. Operationally, this is difficult to accomplish since silicon of variable stoichiometry are nitrides deposited from gas mixtures depending on compositional, thermal, and surface variation in the deposition environment. Proposals for alternate silicon nitride sources that should lead to more uniform stoichiometry include single monomer approaches. Reinbergl has reported trisilylamine [(H3 Si)3 N] as a silicon nitride source, but the material is difficult to prepare and is pyrophoric. Other approaches to silicon nitride sources are found in the ceramic field. These include polysilazane, polyorganosilazanes and a variety of non-volatile resinous materials such as sesquisilazanes which are not suitable for the production of thin films of silicon nitride. Moreover, polysilazanes in which there is no carbon substitution have poor storage stability, while previously reported organosilazanes yield high levels of silicon carbide on pyrolysis.3,4,5

In this report the formation of silicon nitride from cyclic and linear organosilazane prepolymers is reported. The materials having the following structure were prepared in cyclic and linear forms. Poly(1,1-dimethylsilazane) is included for comparison with earlier work.

Table I.

			Cyclic		Poly	Polymer	
			n	bp	sp.gr.	visc.	
[1] Me Si Me	H-N H-N		3	186-8°		>1000 ctsk.	
[2] Me Si H	Me N		3	56°/5mm	.99	600-700 ctsk.	
[3] Me Si H	Me N Si H	H N n/2	4	202-206°	1.04	150-250 ctsk.	

Structure & Physical Properties of Organosilazanes

The cyclic silazanes are readily prepared by one or two stage aminolysis reactions, e.g.

Me Me Me Me [4] 2 MeHSiCl₂ + 3 MeNH₂
$$\longrightarrow$$
 Cl - Si - N - Si - Cl + 2MeNH₂Cl H H

The linear polymers are prepared by catalytic reequilibration of the cyclic materials at 225-300°C. They are soluble in hydrocarbons.

Essentially identical compositions result from the pyrolysis of cyclic or linear organosilazanes at pyrolysis temperatures of $350\,^{\circ}\text{C}$ or greater. Complete conversion to ceramic occurs at temperatures exceeding $700\,^{\circ}\text{C}$. Slight changes in morphology without changes in elemental composition appear to occur at higher temperatures.

Table II.

Thermal Characteristics

Polymer	Principal Endotherm*	Silicon Nitride** Content%	Yield %
1.	440-450°	30-40	5-10
2.	375-385°	50-60	15-20
3.	286-287°	80-85	50-55

1,1-dimethylsilazanes and 1,2-dimethylsilazanes have the same ratio of silicon, nitrogen, and hydrogen. The 1,2-dimethy1silazanes undergo conversion at lower temperatures to higher levels of silicon nitride at higher yields. This may be accounted for by the lower bond dissociation of N-CH3 compared to Si-CH3.6 The dramatic yield enhancement in the 1,2-dimethylsilazane-1methylsilazane copolymer may be accounted for by several factors: The carbon content is lower, the bond dissociation energies of N-CH3 vs. Si-CH3, and the ability of the relatively basic nitrogen to react with silicon hydride generating hydrogen byproduct. It should be noted that although the base interaction with silicon hydride is the likely cause of poor stability in inorganic polysilazanes, the methyl substituted silicon hydrides appear to have acceptable stability.

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- * Determined by DSC 10°/min under N2.
- ** Calculation from stoichiometries, balance SiC.

Figure 1.

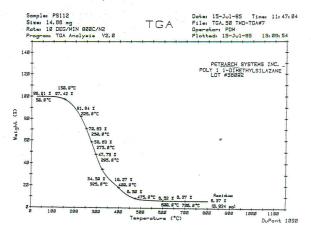


Figure 2.

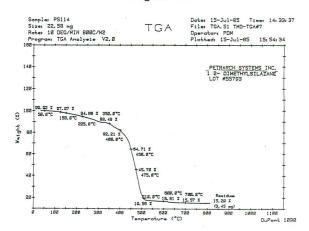
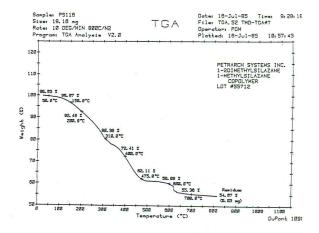


Figure 3.



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